Search Notes

Application/Cont	rol No.	Applicant(s) Reexaminat	/Patent under ion
09/644,463		HAYCOCK	ET AL.
Examiner		Art Unit	
Raymond Phan		2111	

	SFAR	CHED	
	JLAN		
Class	Subclass	Date	Examiner
710	305-306, 308-315, 104-106	12/17/2005	RP
710	58-61	12/17/2005	RP
710	31-38	12/17/2005	RP
326	83,86-87	12/18/2005	RP
326	56-58	12/18/2005	RP
216	20-22	12/18/2005	RP

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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